

## **Description**

The IRFP450 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

 $V_{DS} = 500V I_{D} = 14A$ 

 $R_{DS(ON)} < 0.5\Omega$ @  $V_{GS}$ =10V

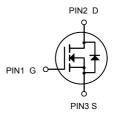
#### **Application**

Battery protection

Load switch

Uninterruptible power supply





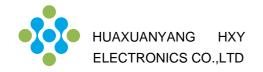
N-Channel MOSFET

# **Package Marking and Ordering Information**

Product ID	Pack	Marking	Qty(PCS)
IRFP450	TO-247S(TO-247AC-3)	IRFP450 XXXX	30

#### Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	500	V
Vgs	Gate-Source Voltage	±20	V
Ip@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	14	Α
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	8.7	А
Ірм	Pulsed Drain Current <sup>2</sup>	56	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	760	mJ
las	Avalanche Current	8.7	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	190	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R <sub>thJA</sub>	Maximum Junction-to-Ambient	40	°C/W
R <sub>thJC</sub>	Maximum Junction-to-Case (Drain)	0.65	°C/W



#### Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Те	st Conditions	Min.	Тур.	Max.	Unit
Static							•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.63	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zana Cata Valtana Dunin Cumunt	1	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	25	μA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 8.4A <sup>b</sup>	-	0.43	0.5	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 5$	0 V, I <sub>D</sub> = 8.4 A <sup>b</sup>	9.3	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	2600	-	pF
Output Capacitance	C <sub>oss</sub>	V	$V_{DS} = 25 \text{ V},$		720	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	340	-	
Total Gate Charge	Qg	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 14 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b</sup>	-	-	150	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	20	
Gate-Drain Charge	$Q_{gd}$			-	-	80	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 250 V, $I_{D}$ = 14 A, $R_{G}$ = 6.2 Ω, $R_{D}$ = 17 Ω, see fig. 10 <sup>b</sup>		-	17	-	ns ns
Rise Time	t <sub>r</sub>			-	47	-	
Turn-Off Delay Time	$t_{d(off)}$			-	92	-	
Fall Time	t <sub>f</sub>			-	44	-	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		ı	5.0	-	5 <u>U</u>
Internal Source Inductance	L <sub>S</sub>			ı	13	-	nH
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			ı	-	56	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 14 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}$ , $I_F = 14 \text{A}$ , $dI/dt = 100 \text{A}/\mu\text{s}^b$		•	540	810	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>				4.8	7.2	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			L <sub>D</sub> )		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### **Typical Characteristics** Ta = 25 °C, unless otherwise noted

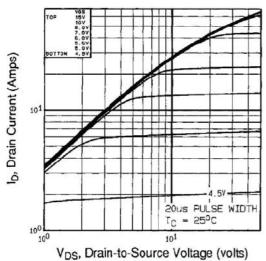


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

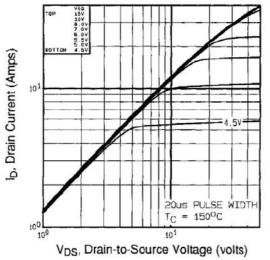


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

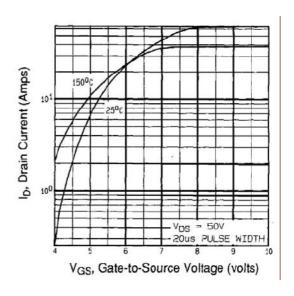


Fig. 3 - Typical Transfer Characteristics

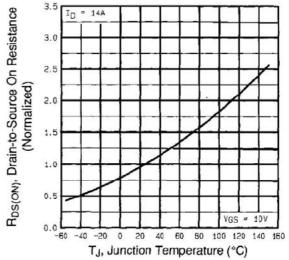


Fig. 4 - Normalized On-Resistance vs. Temperature



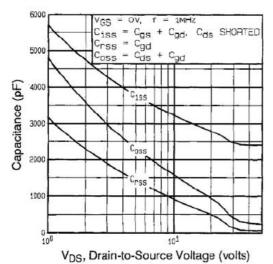


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

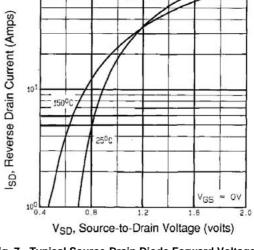


Fig. 7 - Typical Source-Drain Diode Forward Voltage

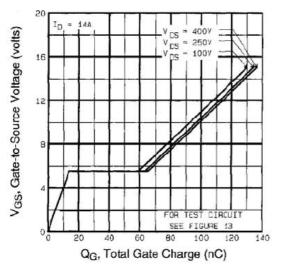


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

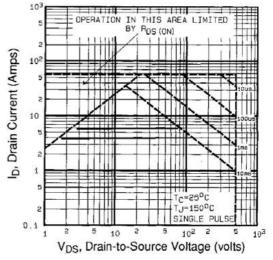


Fig. 8 - Maximum Safe Operating Area

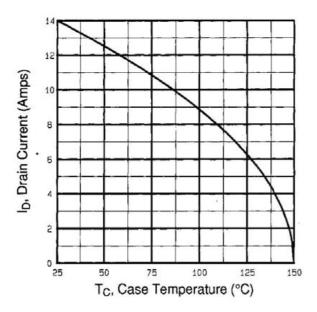


Fig. 9 - Maximum Drain Current vs. Case Temperature

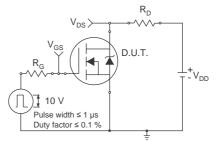


Fig. 10a - Switching Time Test Circuit

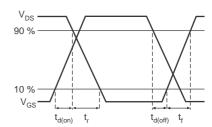


Fig. 10b - Switching Time Waveforms

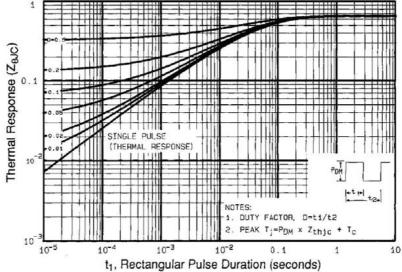


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

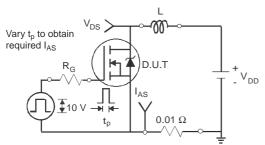


Fig. 12a - Unclamped Inductive Test Circuit

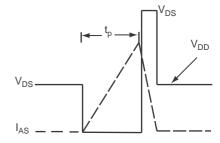


Fig. 12b - Unclamped Inductive Waveforms



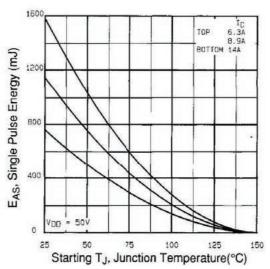


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

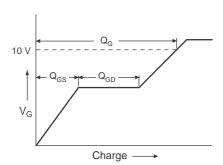


Fig. 13a - Basic Gate Charge Waveform

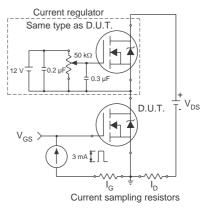
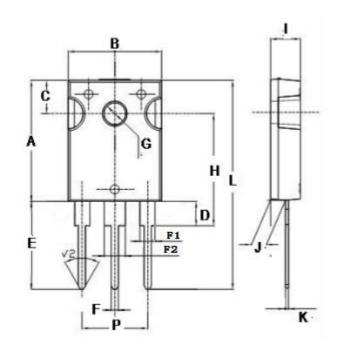


Fig. 13b - Gate Charge Test Circuit



# TO-247S(TO-247AC-3 ) Package Information



D:	N 4:	N 4		
Dim	Min	Max		
Α	20.0	22.0		
В	15.5	16.0		
С	5.7	6.3		
D	4.0	4.4		
Е	19.0	21.0		
F	1.1	1.3		
G	3.5	3.8		
Н	18.3	20.2		
I	4.9	5.2		
J	2.3	2.5		
K	0.55	0.65		
L	39.0	42.0		
Р	10.7	10.9		
F1	1.9	2.1		
F2	2.9	3.1		
	mm			



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